



### 20V P-CHANNEL ENHANCEMENT MODE MOSFET

### **Product Summary**

V <sub>(BR)DSS</sub>	R <sub>DS(on) max</sub>	I <sub>D</sub> T <sub>A</sub> = +25°C
-20V	$95m\Omega @ V_{GS} = -4.5V$	3.0A
-201	$130m\Omega @ V_{GS} = -2.5V$	2.5A

### Description

This new generation MOSFET has been designed to minimize the onstate resistance ( $R_{DS(ON)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

## **Applications**

- DC-DC Converters
- Power Management Functions
- Analog Switch

### **Features and Benefits**

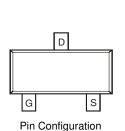
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 standards for High Reliability

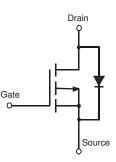
### **Mechanical Data**

- Case: SOT23
- Case Material: Molded Plastic, "Green" Molding Compound.
  UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin annealed over Copper leadframe. Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.0072 grams (approximate)



Top View





Internal Schematic

### Ordering Information (Note 4)

Part Number	Case	Packaging
DMG3413L-7	SOT23	3,000/Tape & Reel

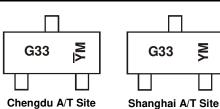
Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.

2. See http://www.diodes.com/quality/lead\_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.

3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.

4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

# **Marking Information**



G33 = Marking Code YM = Date Code Marking for SAT (Shanghai Assembly/ Test site)  $\overline{YM}$  = Date Code Marking for CAT (Chengdu Assembly/ Test site) Y or  $\overline{Y}$  = Year (ex: A = 2013) M = Month (ex: 9 = September)

Date Code Key	,											
Year	2010	20	11	2012	2013	20	14	2015	2016	20	17	2018
Code	Х		(	Z	А	l	3	С	D	E	E	F
Month	Jan	Feb	Mar	Apr	Мау	Jun	Jul	Aug	Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



# **Maximum Ratings** (@ $T_A = +25^{\circ}C$ , unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Total Power Dissipation (Note 5)		PD	0.7	W	
Thermal Desistance, lunction to Ambient (Note E)	Steady State	D	184	°C/W	
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	R <sub>0JA</sub>	115	-C/W	
Total Power Dissipation (Note 6)		PD	1.3	W	
Thermal Desistance, lunction to Ambient (Note C)	Steady State	D	94		
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	R <sub>θJA</sub>	61	°C/W	
Thermal Resistance, Junction to Case		R <sub>eJC</sub>	25		
Operating and Storage Temperature Range		T <sub>J.</sub> T <sub>STG</sub>	-55 to +150	°C	

### Thermal Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units		
Drain-Source Voltage		V <sub>DSS</sub>	-20	V	
Gate-Source Voltage			V <sub>GSS</sub>	±8	V
	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	ID	3.0 2.4	A
Continuous Drain Current (Note 6) $V_{GS} = -4.5V$	t<10s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	ID	3.7 2.9	А
Continuous Drain Current (Note 6) )/ 25/	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	ID	2.5 2.0	А
Continuous Drain Current (Note 6) V <sub>GS</sub> = -2.5V	t<10s	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	ID	3.2 2.5	A
Maximum Continuous Body Diode Forward Curren	Is	1.9	A		
Pulsed Drain Current (10µs pulse, duty cycle = 1%		I <sub>DM</sub>	20	A	

### Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	-20	—	—	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	l	_	-1.0	μA	$V_{DS} = -16V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>		_	±100	nA	$V_{GS} = \pm 8V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V <sub>GS(th)</sub>	-0.6	-0.55	-1.3	V	$V_{DS} = V_{GS}, I_D = -250 \mu A$	
			73	95		$V_{GS} = -4.5V, I_D = -3.0A$	
Static Drain-Source On-Resistance	R <sub>DS(ON)</sub>	—	95	130	mΩ	$V_{GS} = -2.5V, I_D = -2.6A$	
			146	190		$V_{GS} = -1.8V, I_D = -1A$	
Forward Transfer Admittance	Y <sub>fs</sub>	_	8	-	S	$V_{DS} = -5V, I_D = -3A$	
Diode Forward Voltage	V <sub>SD</sub>	_	-0.8	-1.25	V	$V_{GS} = 0V, I_{S} = -1A$	
DYNAMIC CHARACTERISTICS (Note 8)						·	
Input Capacitance	Ciss		857	—	pF		
Output Capacitance	Coss		54	—	pF	−V <sub>DS</sub> = -10V, V <sub>GS</sub> = 0V −f = 1.0MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>		49	—	pF	1 = 1.000112	
Gate Resistnace	Rg		12.3	—	Ω	$V_{DS} = 0V, V_{GS} = 0V, f = 1.0MHz$	
Total Gate Charge	Qg	_	9.0	—	nC		
Gate-Source Charge	Q <sub>gs</sub>		1.6	—	nC	$V_{GS} = -4.5V, V_{DS} = -15V, I_{D} = -4A$	
Gate-Drain Charge	Q <sub>gd</sub>	_	1.1	—	nC		
Turn-On Delay Time	t <sub>D(on)</sub>		9.7	—	ns		
Turn-On Rise Time	tr	_	17.7	—	ns	V <sub>DS</sub> = -15V, V <sub>GS</sub> = -10V,	
Turn-Off Delay Time	t <sub>D(off)</sub>	_	268.8	—	ns	$R_L = 15\Omega, R_G = 6.0\Omega, I_D = -1A$	
Turn-Off Fall Time	t <sub>f</sub>	_	64.2	_	ns		

Notes:

Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.
 Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1inch square copper plate 7 .Short duration pulse test used to minimize self-heating effect.
 Guaranteed by design. Not subject to production testing.

3.0

2.5

T<sub>A</sub> = 150°C

T<sub>A</sub> = 125°C

 $T_A = 85^{\circ}C$ 

 $T_A = 25^{\circ}C$ 

T<sub>A</sub> = -55°C

10

12

8

-V<sub>GS</sub> = 2.5V -I<sub>D</sub> = 3.0A

-V<sub>GS</sub> = 4.5V -I<sub>D</sub> = 5A

100

125

-I<sub>D</sub>

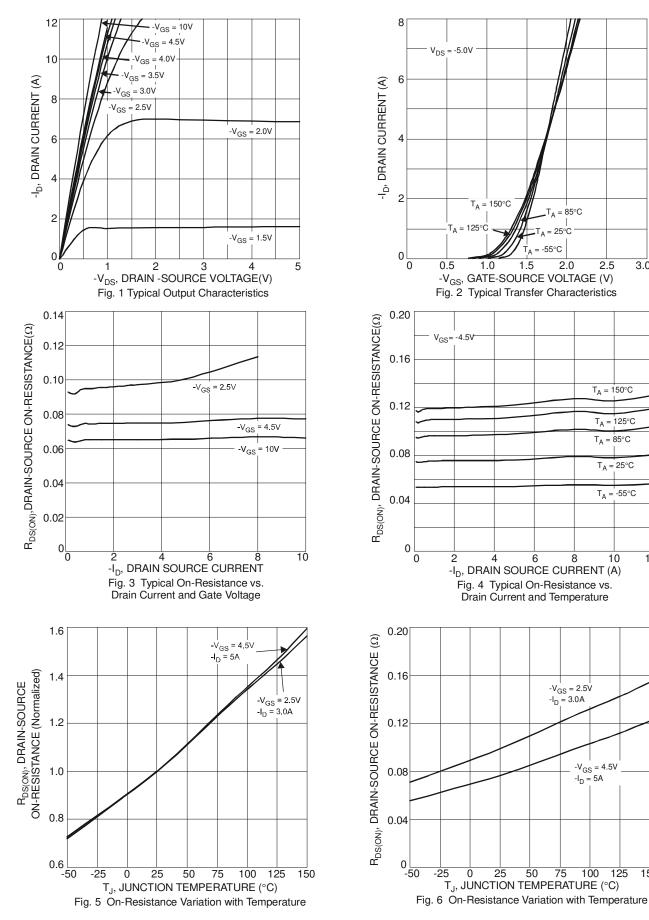
75

= 85°C

25°C

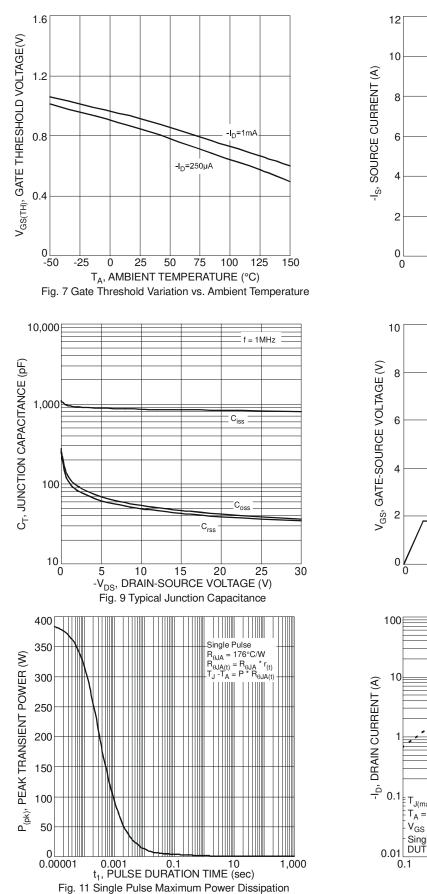
2.0

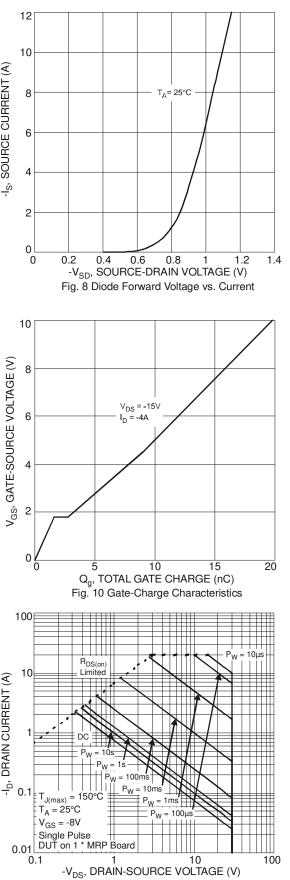




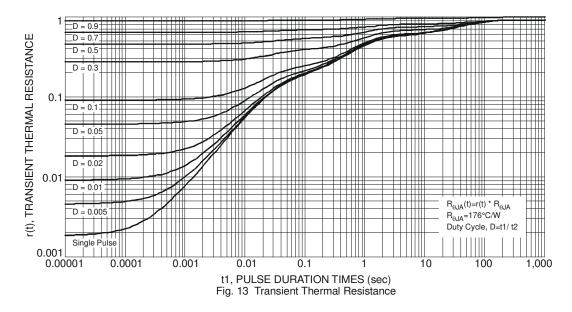
150





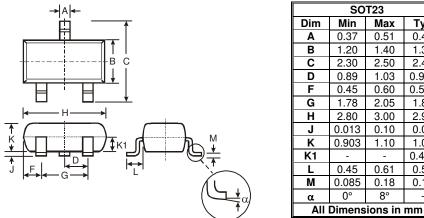






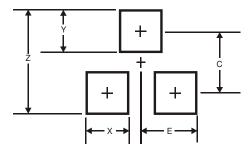
## **Package Outline Dimensions**

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.



# **Suggested Pad Layout**

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
Z	2.9
Х	0.8
Y	0.9
С	2.0
E	1.35

Max

0.51

1.40

2.50

1.03

0.60

2.05

3.00

0.10

1.10

-

0.61

0.18

8°

Тур 0.40

1.30

2.40

0.915

0.535

1.83

2.90

0.05

1.00

0.400

0.55

0.11



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